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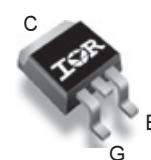
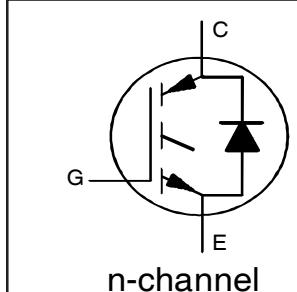
Insulated Gate Bipolar Transistor with Ultrafast Soft Recovery Diode

$V_{CES} = 600V$

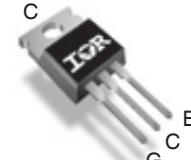
$I_C = 15A, T_C = 100^\circ C$

$t_{sc} > 5\mu s, T_{jmax} = 175^\circ C$

$V_{CE(on)} \text{ typ.} = 1.55V @ 8A$



D²-Pak
IRGS4615DPbF



TO-220AB
IRGB4615DPbF

G	C	E
Gate	Collector	Emitter

Applications

- Appliance Drives
- Inverters
- UPS

Features	→	Benefits
Low $V_{CE(ON)}$ and switching losses		High efficiency in a wide range of applications and switching frequencies
Square RBSOA and maximum junction temperature $175^\circ C$		Improved reliability due to rugged hard switching performance and higher power capability
Positive $V_{CE(ON)}$ temperature coefficient and tighter distribution of parameters		Excellent current sharing in parallel operation
5μs short circuit SOA		Enables short circuit protection scheme
Lead-free, RoHS compliant		Environmentally friendly

Base part number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRGS4615DPbF	D ² PAK	Tube	50	IRGS4615DPbF
IRGS4615DTRRPbF		Tape and Reel Right	800	IRGS4615DTRRPbF
IRGS4615DTRLPbF		Tape and Reel Left	800	IRGS4615DTRLPbF
IRGB4615DPbF	TO-220AB	Tube	50	IRGB4615DPbF

Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Breakdown Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	23	
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	15	
I_{CM}	Pulsed Collector Current, $V_{GE} = 15V$	24	
I_{LM}	Clamped Inductive Load Current, $V_{GE} = 20V$ ①	32	A
$I_F @ T_C=25^\circ C$	Diode Continuous Forward Current	14	
$I_F @ T_C=100^\circ C$	Diode Continuous Forward Current	9	
I_{FM}	Diode Maximum Forward Current ④	32	
V_{GE}	Continuous Gate-to-Emitter Voltage	± 20	V
	Transient Gate-to-Emitter Voltage	± 30	
$P_D @ T_C = 25^\circ$	Maximum Power Dissipation	99	W
$P_D @ T_C = 100^\circ$	Maximum Power Dissipation	50	
T_J T_{STG}	Operating Junction and Storage Temperature Range	-40 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
Mounting Torque, 6-32 or M3 Screw TO-220		10lbf. In (1.1 N.m)	

Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R _{θJC}	Thermal Resistance, Junction-to-Case -(each IGBT) ②	—	—	1.51	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case -(each Diode) ②	—	—	3.66	
R _{θCS}	Thermal Resistance, Case-to-Sink (flat, greased surface)	—	0.5	—	
R _{θJA}	Thermal Resistance, Junction-to-Ambient (PCB mount D ² PAK) ⑥	—	—	40	
	Thermal Resistance, Junction-to-Ambient (Socket mount: TO-220)	—	—	62	

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
V _{(BR)CES}	Collector-to-Emitter Breakdown Voltage	600	—	—	V	V _{GE} = 0V, I _C = 100 μA ③
ΔV _{(BR)CES/ΔTJ}	Temperature Coeff. of Breakdown Voltage	—	0.3	—	V/°C	V _{GE} = 0V, I _C = 250μA (25 -175°C)
V _{CE(on)}	Collector-to-Emitter Saturation Voltage	—	1.55	1.85	V	I _C = 8.0A, V _{GE} = 15V, T _J = 25°C
		—	1.95	—		I _C = 8.0A, V _{GE} = 15V, T _J = 150°C
		—	2.00	—		I _C = 8.0A, V _{GE} = 15V, T _J = 175°C
V _{GE(th)}	Gate Threshold Voltage	4.0	—	6.5	V	V _{CE} = V _{GE} , I _C = 250μA
ΔV _{GE(th)/ΔTJ}	Threshold Voltage temp. coefficient	—	-18	—	mV/°C	V _{CE} = V _{GE} , I _C = 250μA (25 -175°C)
g _{fe}	Forward Transconductance	—	5.6	—	S	V _{CE} = 50V, I _C = 8.0A, PW =80μs
I _{CES}	Collector-to-Emitter Leakage Current	—	—	25	μA	V _{GE} = 0V, V _{CE} = 600V
		—	400	—		V _{GE} = 0V, V _{CE} = 600V, T _J =175°C
V _{FM}	Diode Forward Voltage Drop	—	1.80	2.8	V	I _F = 8.0A
		—	1.30	—		I _F = 8.0A, T _J = 175°C
I _{GES}	Gate-to-Emitter Leakage Current	—	—	±100	nA	V _{GE} = ± 20 V

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q _g	Total Gate Charge (turn-on)	—	19	—	nC	I _C = 8.0A
Q _{ge}	Gate-to-Emitter Charge (turn-on)	—	5	—		V _{CC} = 400V
Q _{gc}	Gate-to-Collector Charge (turn-on)	—	8	—		V _{GE} = 15V
E _{on}	Turn-On Switching Loss	—	70	—	μJ	I _C = 8.0A, V _{CC} = 400V, V _{GE} = 15V
E _{off}	Turn-Off Switching Loss	—	145	—		R _G = 47Ω, L=1mH, L _S = 150nH, T _J = 25°C
E _{total}	Total Switching Loss	—	215	—		Energy losses include tail and diode reverse recovery ⑤
t _{d(on)}	Turn-On delay time	—	30	—		I _C = 8.0A, V _{CC} = 400V
t _r	Rise time	—	15	—	ns	R _G = 47Ω, L=1mH, L _S = 150nH
t _{d(off)}	Turn-Off delay time	—	95	—		T _J = 25°C
t _f	Fall time	—	20	—		
E _{on}	Turn-On Switching Loss	—	165	—	μJ	I _C = 8.0A, V _{CC} = 400V, V _{GE} = 15V
E _{off}	Turn-Off Switching Loss	—	240	—		R _G = 47Ω, L=1mH, L _S = 150nH, T _J = 175°C
E _{total}	Total Switching Loss	—	405	—		Energy losses include tail and diode reverse recovery ⑤
t _{d(on)}	Turn-On delay time	—	28	—		I _C = 8.0A, V _{CC} = 400V
t _r	Rise time	—	17	—	ns	R _G = 47Ω, L=1mH, L _S = 150nH
t _{d(off)}	Turn-Off delay time	—	117	—		T _J = 175°C
t _f	Fall time	—	35	—		
C _{ies}	Input Capacitance	—	535	—	pF	V _{GE} = 0V
C _{oes}	Output Capacitance	—	45	—		V _{CC} = 30V
C _{res}	Reverse Transfer Capacitance	—	15	—		f = 1Mhz
RBSOA	Reverse Bias Safe Operating Area	FULL SQUARE				T _J = 175°C, I _C = 32A
						V _{CC} = 480V, V _p =600V R _G = 47Ω, V _{GE} = +20V to 0V
SCSOA	Short Circuit Safe Operating Area	5	—	—	μs	V _{CC} = 400V, V _p =600V R _G = 47Ω, V _{GE} = +15V to 0V
E _{rec}	Reverse recovery energy of the diode	—	165	—	μJ	T _J = 175°C
trr	Diode Reverse recovery time	—	60	—	ns	V _{CC} = 400V, I _F = 8.0A
Irr	Peak Reverse Recovery Current	—	14	—	A	V _{GE} = 15V, R _G = 47Ω, L=1mH, L _S =150nH

Notes:

- ① V_{CC} = 80% (V_{CES}), V_{GE} = 20V, L = 100 μH, R_G = 47 Ω.
- ② R_θ is measured at T_J approximately 90°C.
- ③ Refer to AN-1086 for guidelines for measuring V_{(BR)CES} safely.
- ④ Pulse width limited by max. junction temperature.
- ⑤ Values influenced by parasitic L and C in measurement
- ⑥ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994: <http://www.irf.com/technical-info/appnotes/an-994.pdf>

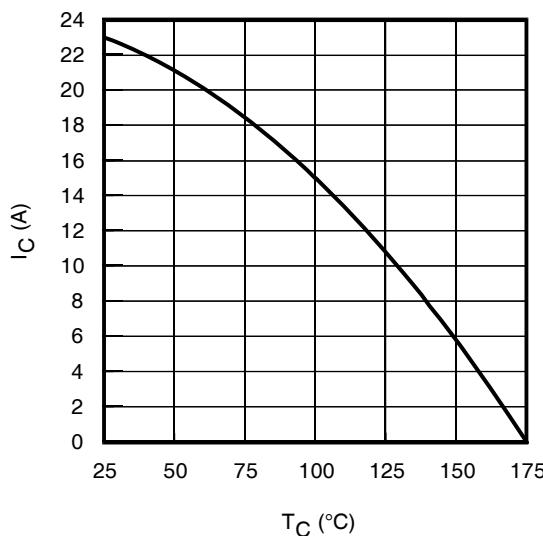


Fig. 1 - Maximum DC Collector Current vs. Case Temperature

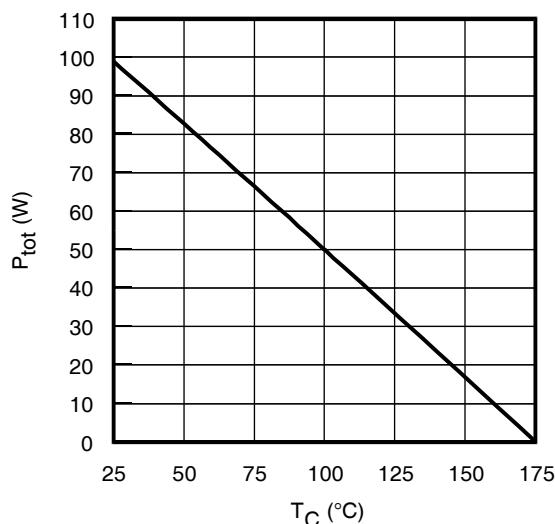
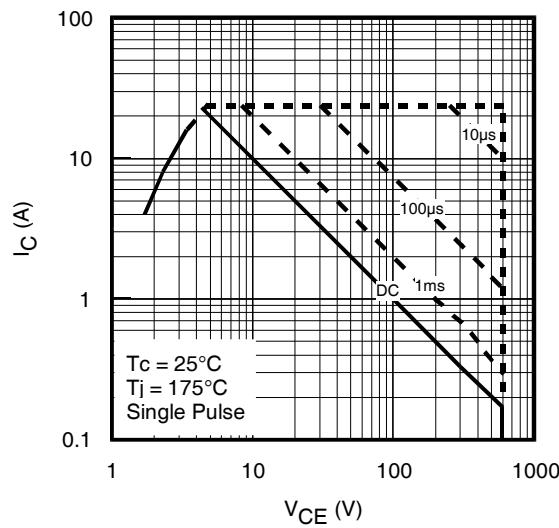
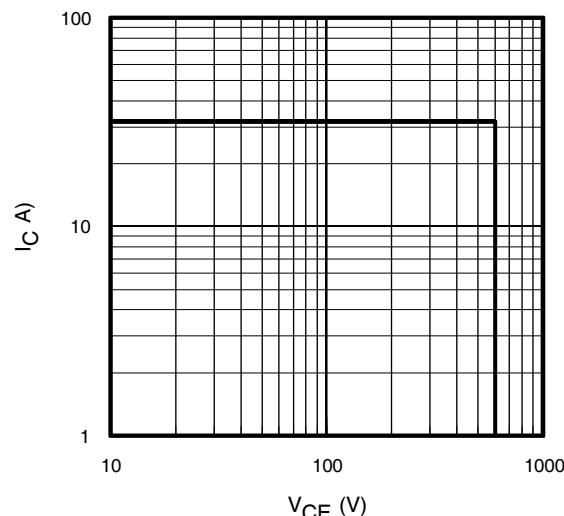


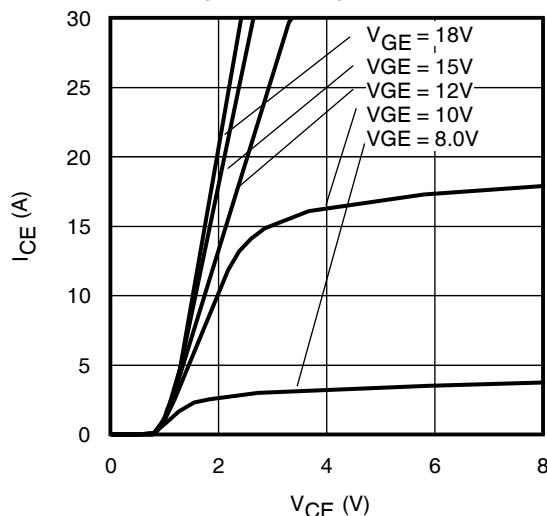
Fig. 2 - Power Dissipation vs. Case Temperature



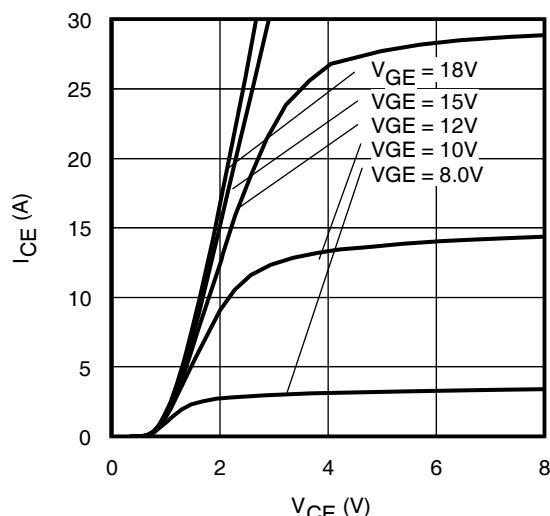
**Fig. 3 - Forward SOA,
 $T_c = 25^\circ\text{C}; T_j \leq 175^\circ\text{C}$**



**Fig. 4 - Reverse Bias SOA
 $T_j = 175^\circ\text{C}; V_{CE} = 15\text{V}$**



**Fig. 5 - Typ. IGBT Output Characteristics
 $T_j = -40^\circ\text{C}; t_p = 80\mu\text{s}$**



**Fig. 6 - Typ. IGBT Output Characteristics
 $T_j = 25^\circ\text{C}; t_p = 80\mu\text{s}$**

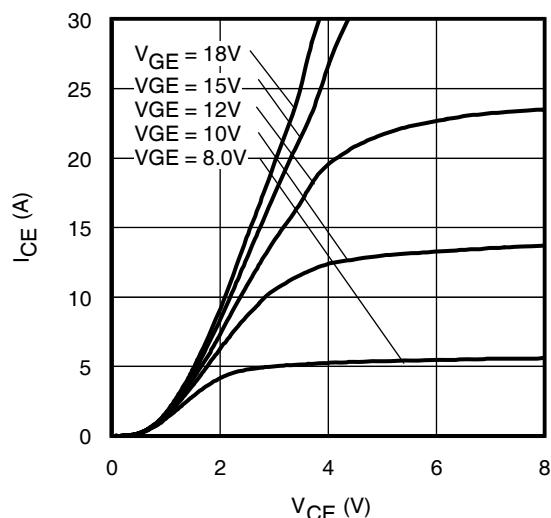


Fig. 7 - Typ. IGBT Output Characteristics
 $T_J = 175^\circ\text{C}$; $t_p = 80\mu\text{s}$

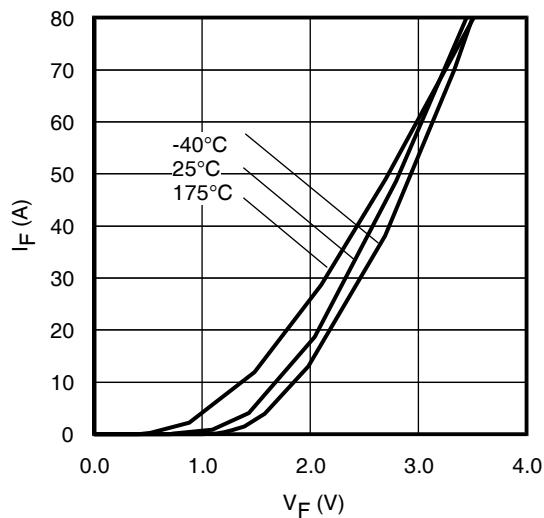


Fig. 8 - Typ. Diode Forward Characteristics
 $t_p = 80\mu\text{s}$

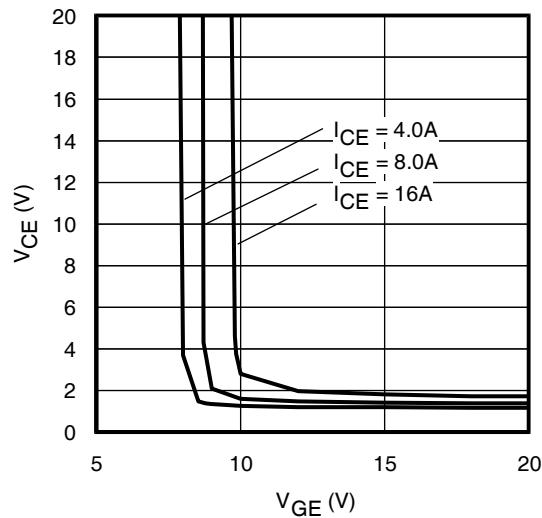


Fig. 9 - Typical V_{CE} vs. V_{GE}
 $T_J = -40^\circ\text{C}$

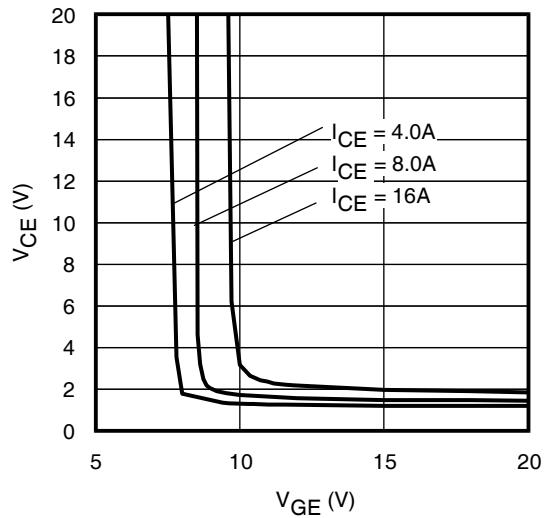


Fig. 10 - Typical V_{CE} vs. V_{GE}
 $T_J = 25^\circ\text{C}$

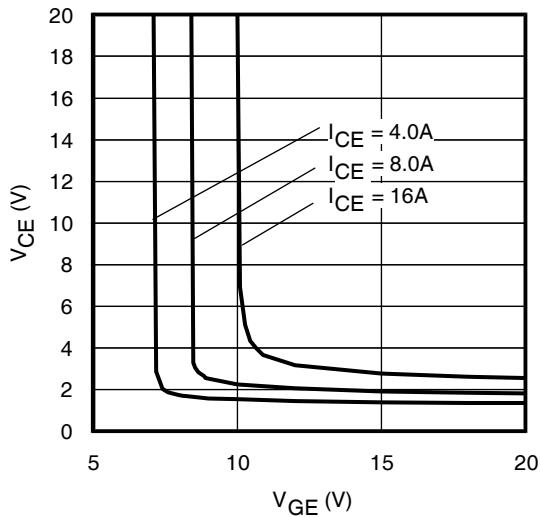


Fig. 11 - Typical V_{CE} vs. V_{GE}
 $T_J = 175^\circ\text{C}$

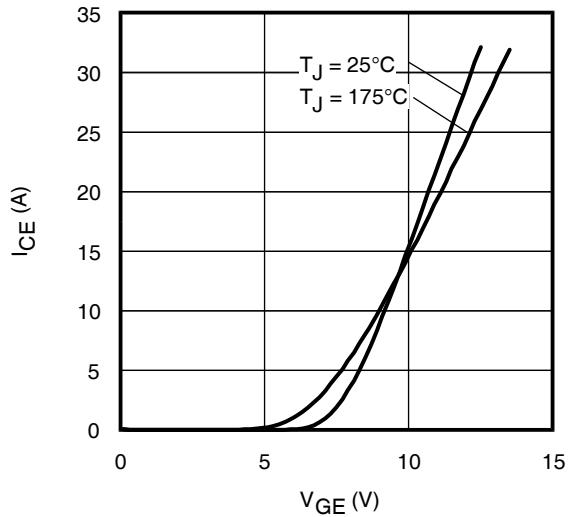


Fig. 12 - Typ. Transfer Characteristics
 $V_{CE} = 50\text{V}$; $t_p = 10\mu\text{s}$

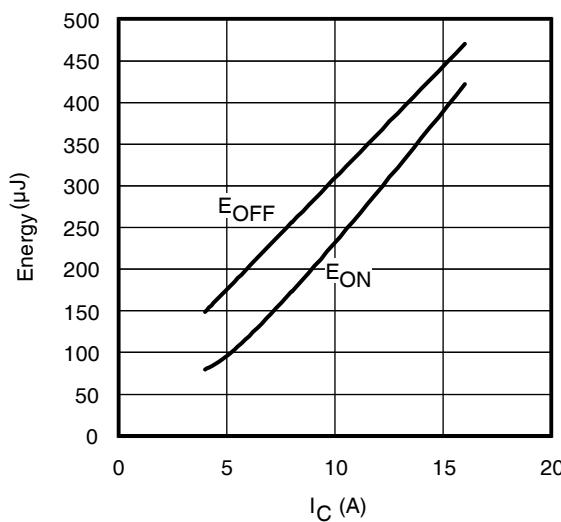


Fig. 13 - Typ. Energy Loss vs. I_C
 $T_J = 175^\circ\text{C}$; $L = 1\text{mH}$; $V_{CE} = 400\text{V}$, $R_G = 47\Omega$; $V_{GE} = 15\text{V}$.

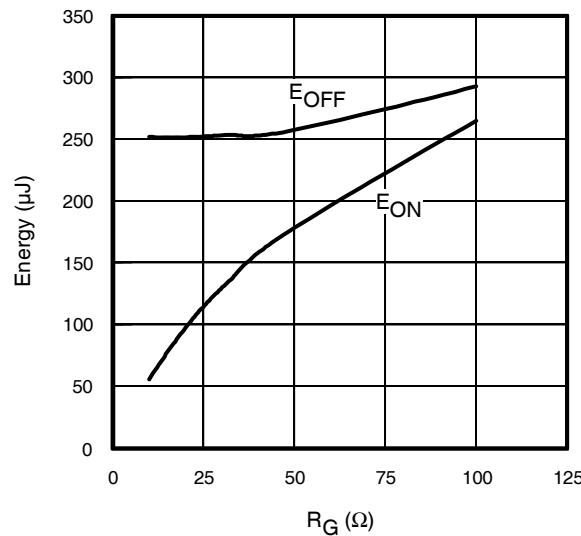


Fig. 15 - Typ. Energy Loss vs. R_G
 $T_J = 175^\circ\text{C}$; $L = 1\text{mH}$; $V_{CE} = 400\text{V}$, $I_{CE} = 8\text{A}$; $V_{GE} = 15\text{V}$

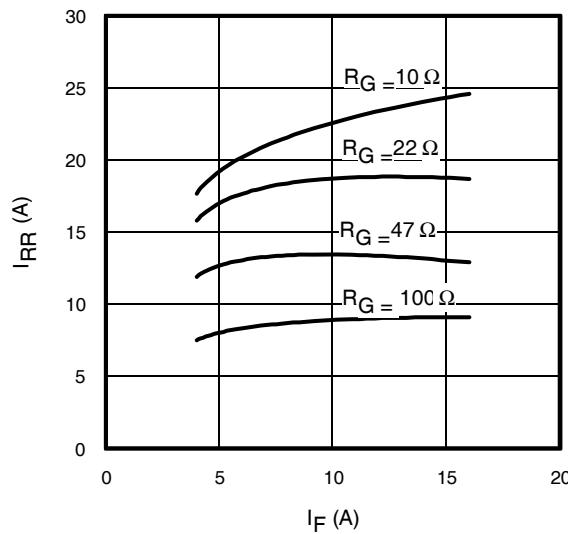


Fig. 17 - Typical Diode I_{RR} vs. I_F
 $T_J = 175^\circ\text{C}$

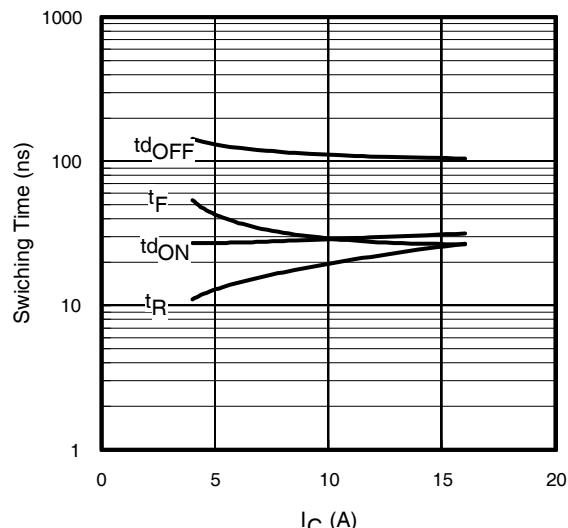


Fig. 14 - Typ. Switching Time vs. I_C
 $T_J = 175^\circ\text{C}$; $L = 1\text{mH}$; $V_{CE} = 400\text{V}$
 $R_G = 47\Omega$; $V_{GE} = 15\text{V}$

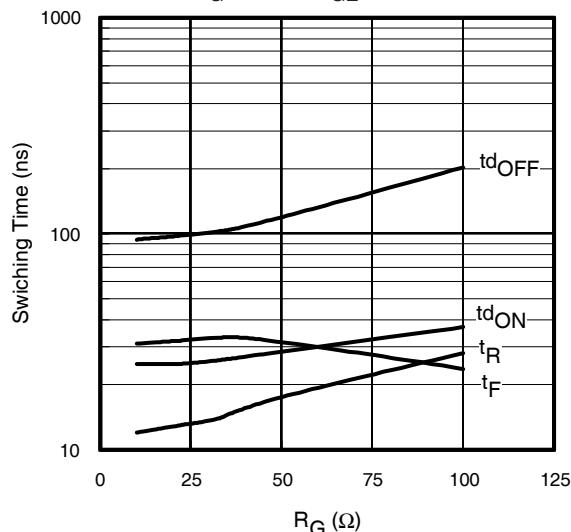


Fig. 16 - Typ. Switching Time vs. R_G
 $T_J = 175^\circ\text{C}$; $L = 1\text{mH}$; $V_{CE} = 400\text{V}$
 $I_{CE} = 8\text{A}$; $V_{GE} = 15\text{V}$

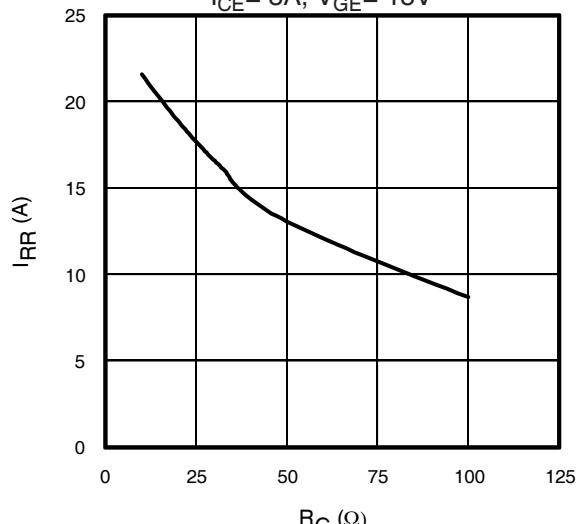


Fig. 18 - Typical Diode I_{RR} vs. R_G
 $T_J = 175^\circ\text{C}$; $I_F = 8.0\text{A}$

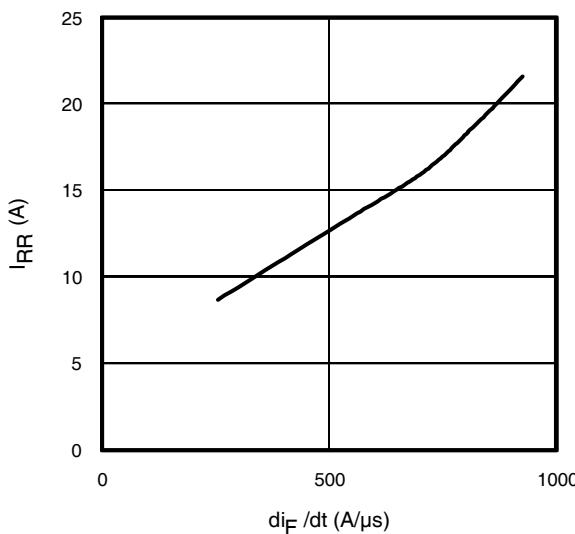


Fig. 19- Typical Diode I_{RR} vs. di_F/dt
 $V_{CC} = 400V$; $V_{GE} = 15V$;
 $I_{CE} = 8A$; $T_J = 175^{\circ}C$

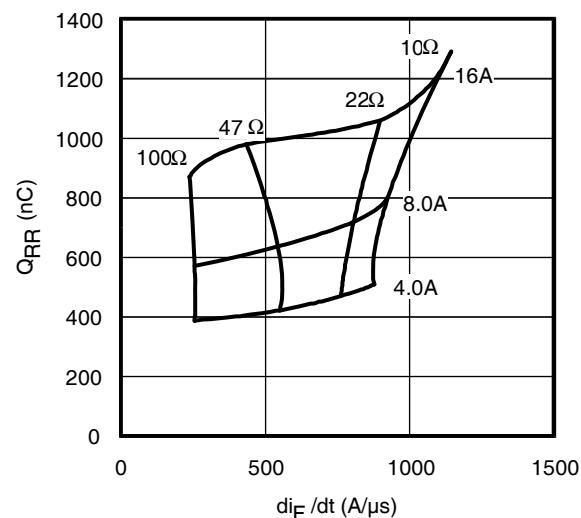


Fig. 20 - Typical Diode Q_{RR}
 $V_{CC} = 400V$; $V_{GE} = 15V$; $T_J = 175^{\circ}C$

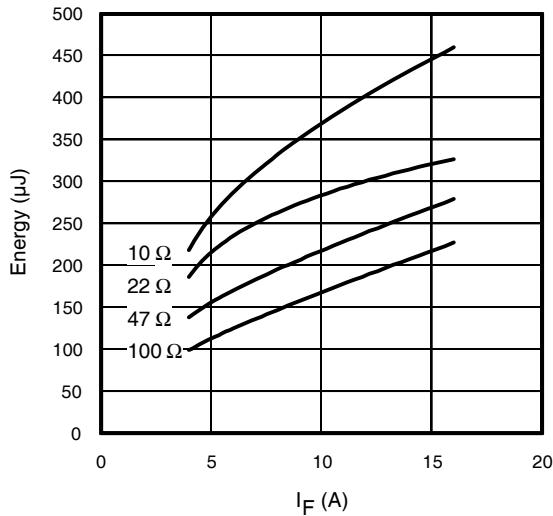


Fig. 21 - Typical Diode E_{RR} vs. I_F
 $T_J = 175^{\circ}C$

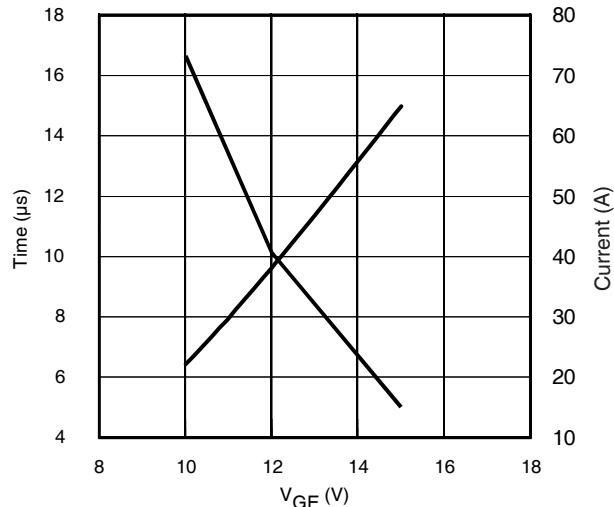


Fig. 22- Typ. V_{GE} vs Short Circuit Time
 $V_{CC}=400V$, $T_C=25^{\circ}C$

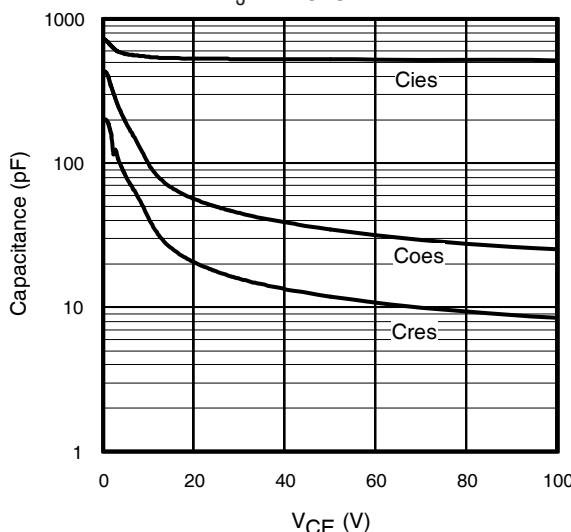


Fig. 23- Typ. Capacitance vs. V_{CE}
 $V_{GE} = 0V$; $f = 1MHz$

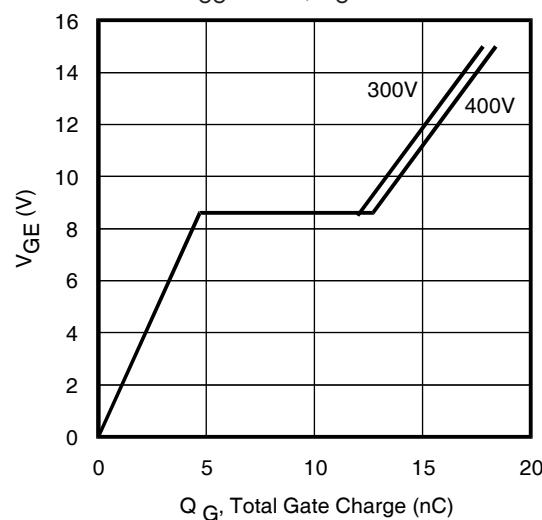


Fig. 24 - Typical Gate Charge vs. V_{GE}
 $I_{CE} = 8A$, $L = 600\mu H$

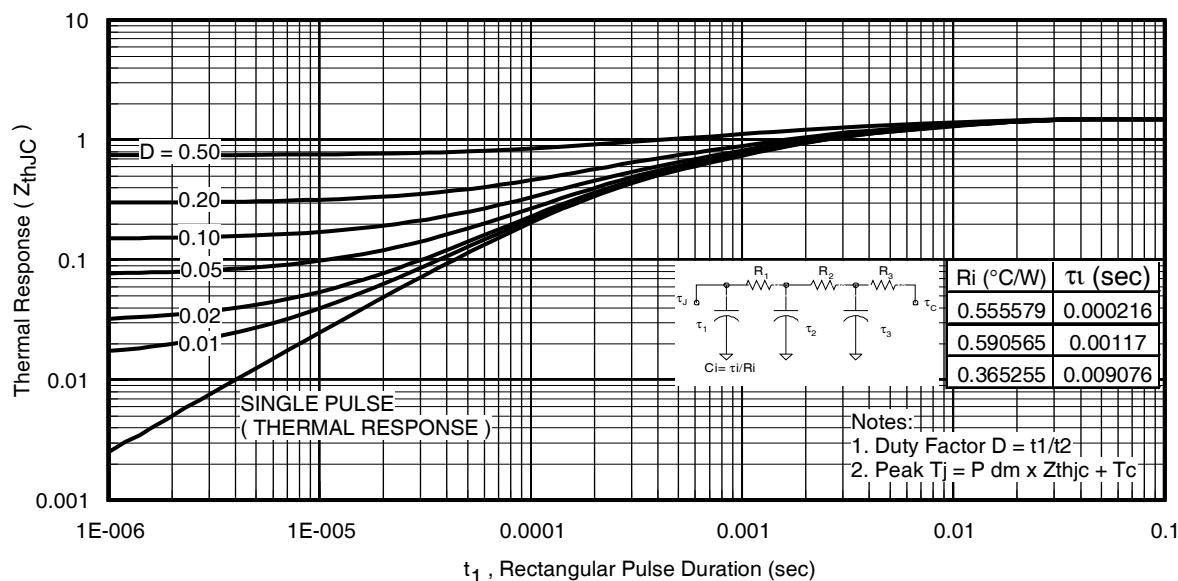


Fig 25. Maximum Transient Thermal Impedance, Junction-to-Case (IGBT)

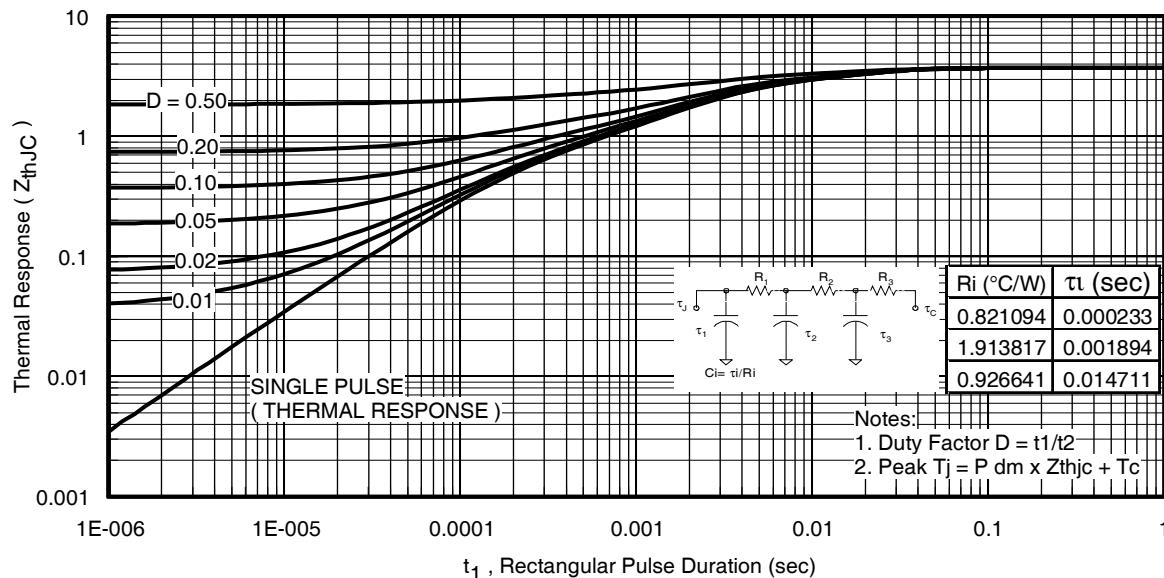


Fig. 26. Maximum Transient Thermal Impedance, Junction-to-Case (DIODE)

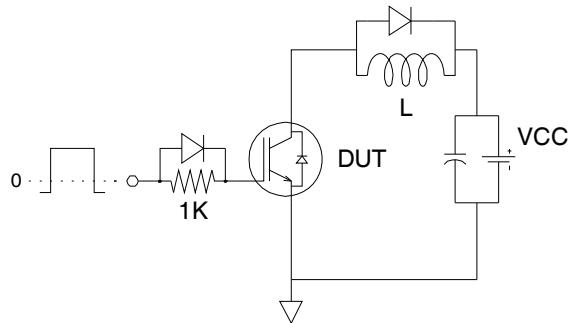


Fig.C.T.1 - Gate Charge Circuit (turn-off)

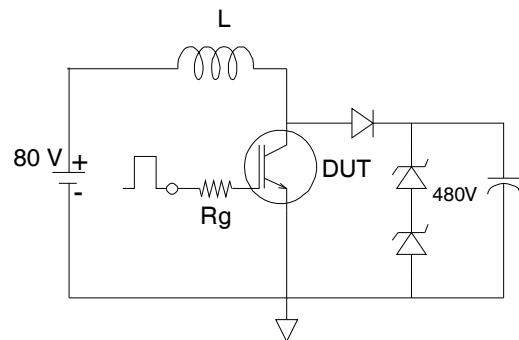


Fig.C.T.2 - RBSOA Circuit

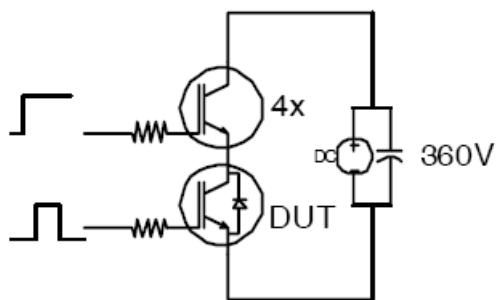


Fig.C.T.3 - S.C.SOA Circuit

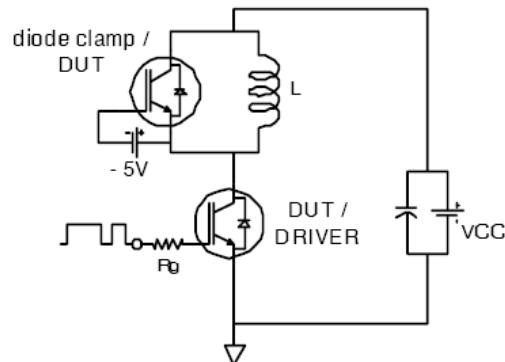


Fig.C.T.4 - Switching Loss Circuit

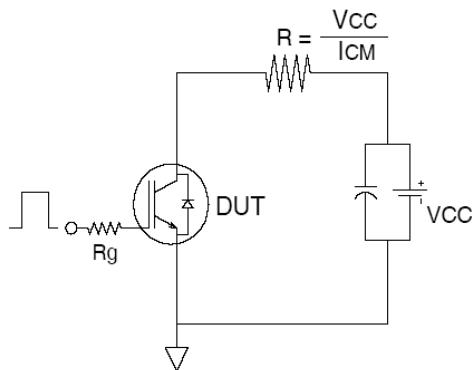
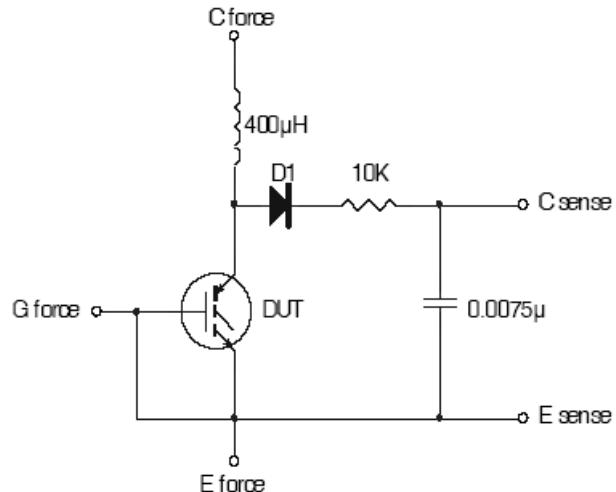


Fig.C.T.5 - Resistive Load Circuit

Fig.C.T.6 - Typical Filter Circuit for
V_{(BR)CES} Measurement

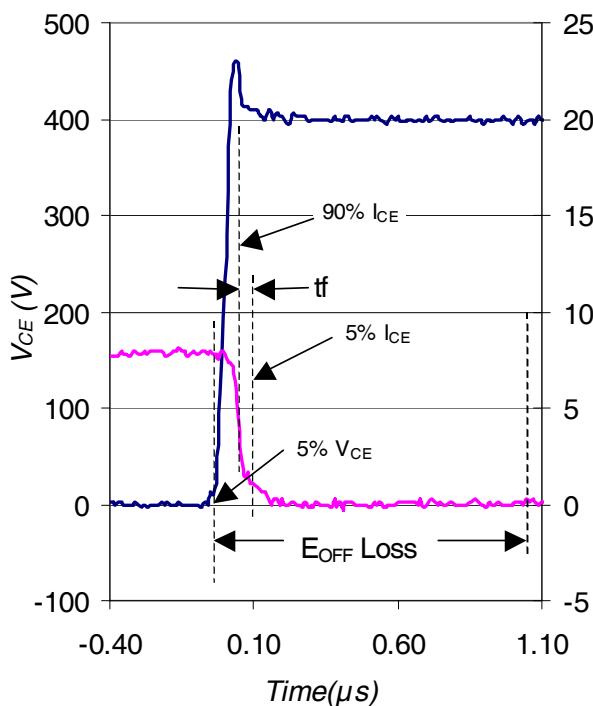


Fig. WF1 - Typ. Turn-off Loss Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

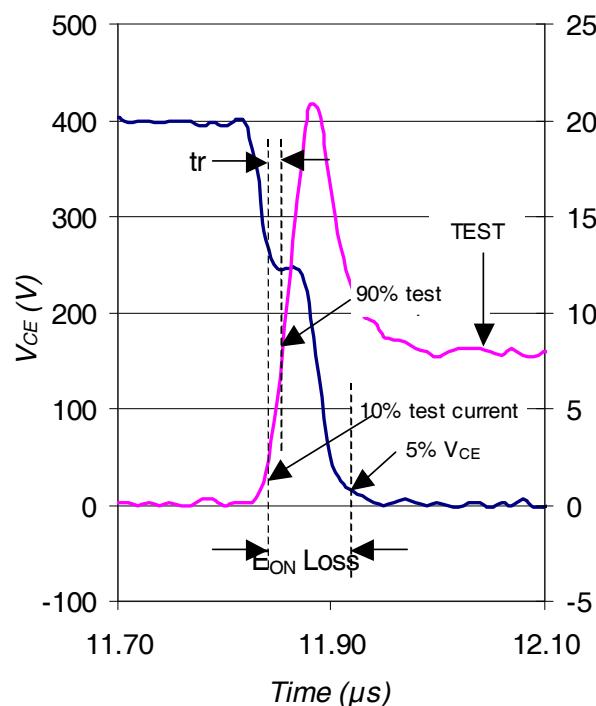
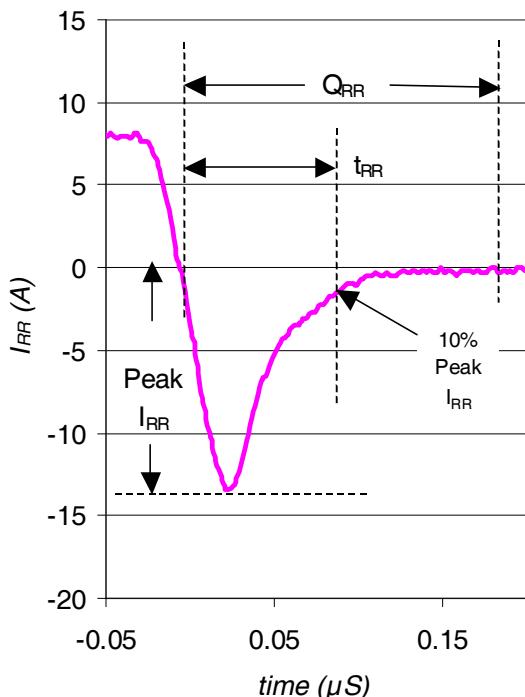
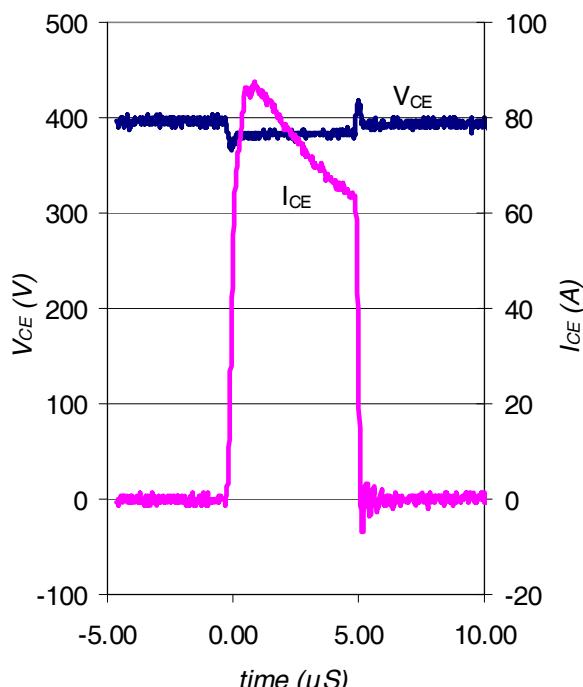


Fig. WF2 - Typ. Turn-on Loss Waveform
@ $T_J = 175^\circ\text{C}$ using Fig. CT.4

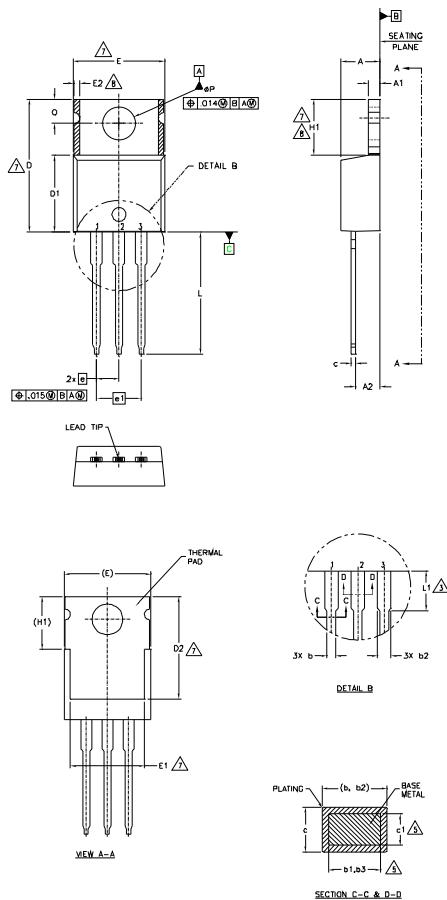


WF.3- Typ. Reverse Recovery Waveform
@ $T_J = 175^\circ\text{C}$ using CT.4



WF.4- Typ. Short Circuit Waveform
@ $T_J = 25^\circ\text{C}$ using CT.3

TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

- 1.- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2.- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- 3.- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4.- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5.- DIMENSION b1, b3 & c1 APPLY TO BASE METAL ONLY.
- 6.- CONTROLLING DIMENSION : INCHES.
- 7.- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- 8.- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- 9.- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	3.56	4.83	.140	.190		
A1	1.14	1.40	.045	.055		
A2	2.03	2.92	.080	.115		
b	0.38	1.01	.015	.040		
b1	0.38	0.97	.015	.038	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
c	0.36	0.61	.014	.024		
c1	0.36	0.56	.014	.022	5	
D	14.22	16.51	.560	.650	4	
D1	8.38	9.02	.330	.355		
D2	11.68	12.88	.460	.507	7	
E	9.65	10.67	.380	.420	4,7	
E1	6.86	8.89	.270	.350	7	
E2	—	0.76	—	.030	8	
e	2.54	BSC	.100	BSC		
e1	5.08	BSC	.200	BSC		
H1	5.84	6.86	.230	.270	7,8	
L	12.70	14.73	.500	.580		
L1	3.56	4.06	.140	.160	3	
ØP	3.54	4.08	.139	.161		
Q	2.54	3.42	.100	.135		

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
2.- DRAIN
3.- SOURCE

IGBTs, CoPACK

- 1.- GATE
2.- COLLECTOR
3.- Emitter

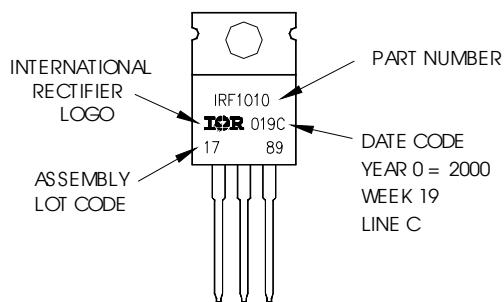
DIODES

- 1.- ANODE
2.- CATHODE
3.- ANODE

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 2000
IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position
indicates "Lead-Free"

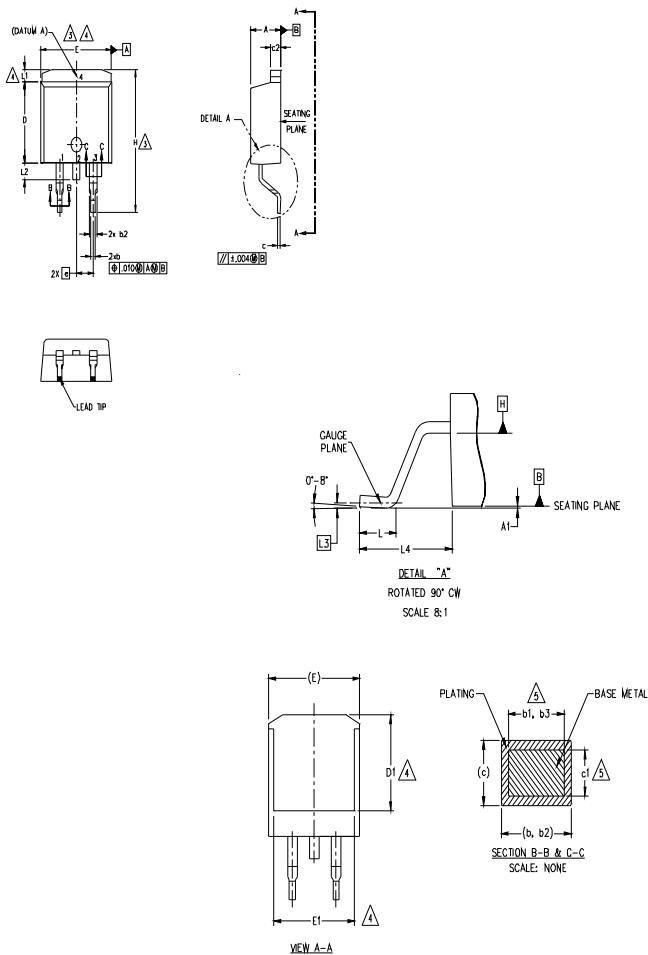


TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

D²Pak Package Outline

Dimensions are shown in millimeters (inches)



SYMBOL	DIMENSIONS				NOTES	
	MILLIMETERS		INCHES			
	MIN.	MAX.	MIN.	MAX.		
A	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
c	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	—	.270		4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	—	.245		4	
e	2.54	BSC	.100	BSC		
H	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1	—	1.65	—	.066		
L2	—	1.78	—	.070		
L3	0.25	BSC	.010	BSC		
L4	4.78	5.28	.188	.208		

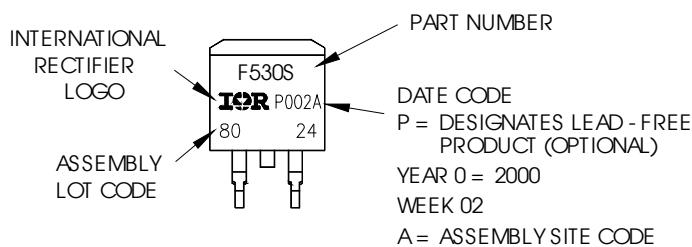
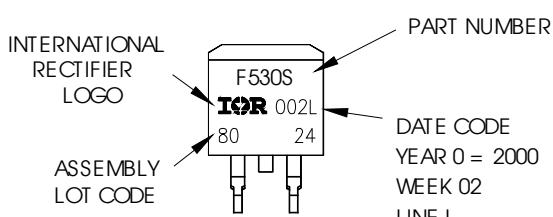
NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 and c1 APPLY TO BASE METAL ONLY.
6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
7. CONTROLLING DIMENSION: INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

D²Pak Part Marking Information

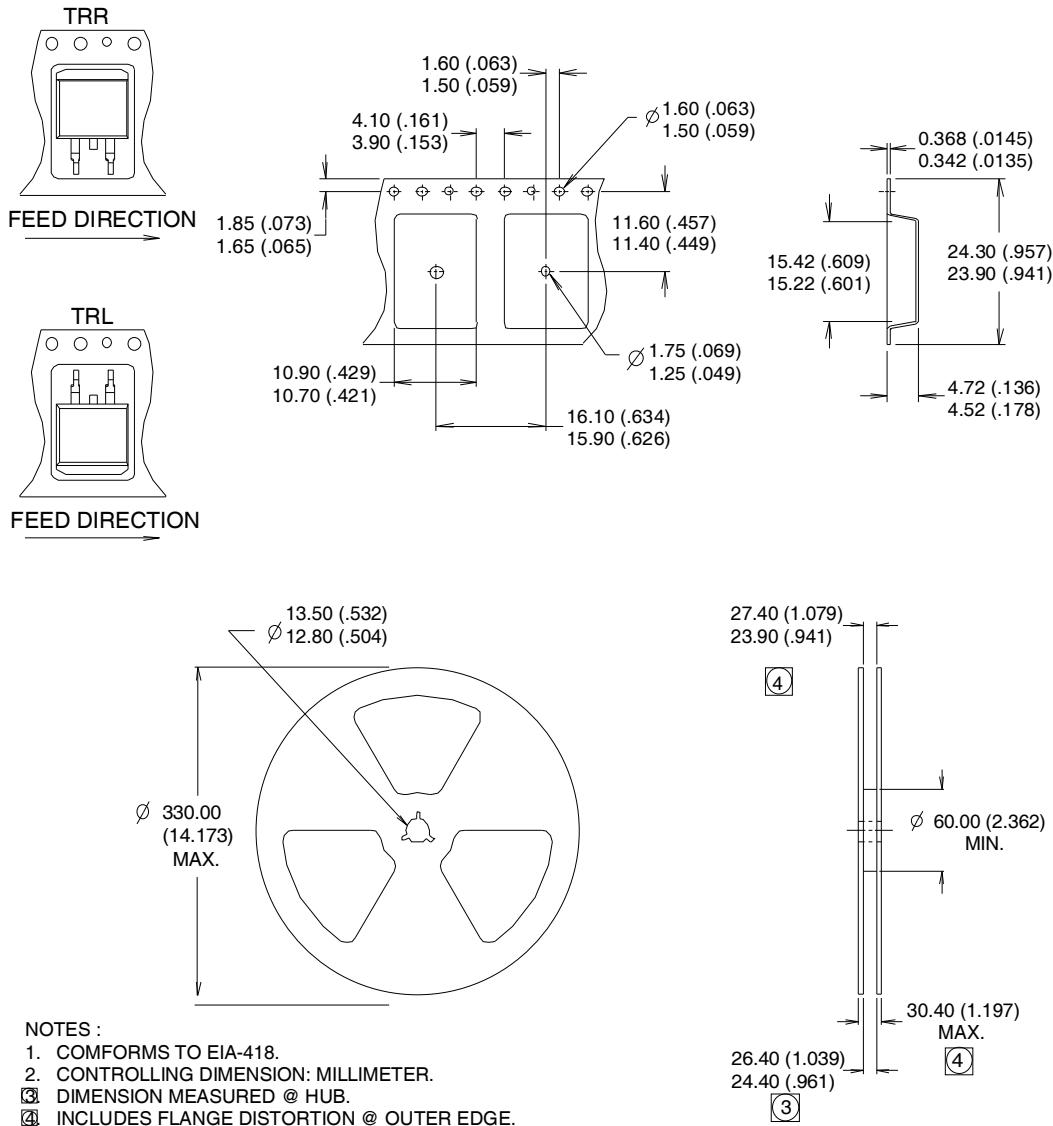
EXAMPLE: THIS IS AN IRF530S WITH
LOT CODE 8024
ASSEMBLED ON WW 02, 2000
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position
indicates "Lead - Free"



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

D²Pak Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Qualification Information[†]

Qualification Level	Industrial (per JEDEC JESD47F) ^{††}	
Moisture Sensitivity Level	D ² Pak	MSL1
	TO-220	N/A
RoHS Compliant	Yes	

[†] Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability>

^{††} Applicable version of JEDEC standard at the time of product release

Revision History

Date	Comments
11/14/2014	<ul style="list-style-type: none">Added note ④ to I_{FM} Diode Maximum Forward Current on page 1.Added note ⑤ to switching losses test condition on page 2.Updated package outline on page 10.

International
 Rectifier

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To contact International Rectifier, please visit <http://www.irf.com/whoto-call/>